

SWR80N06

60V Single N-Channel Enhancement-Mode MOSFET

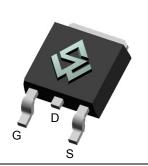
General Description

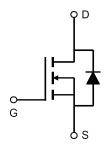
- Low gate charge.
- Use as a load switch.
- Use in PWM applications

Product Summary

- BV_{DSS} 60V
- $R_{DS(on)}$ @VGS = 10V < 7m Ω
- $R_{DS(on)}$ @VGS = 4.5V < 12m Ω

TO-252 D-PAK





Absolute Maximum Ratings (T_A = 25°C unless otherwise noted)

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V _{DS}	60	V
Gate-Source Voltage	V_{GS}	±20	V
Drain Current (T _C =25°C)		80	A
Drain Current (T _C =75°C)		52	
Drain Current (T _A =25°C)	l _D	50	
Drain Current (T _A =75°C)		30	
Pulsed Drain Current ^a	I _{DM}	320	Α
Single Pulsed Avalanche Energy ^e	Pulsed Avalanche Energy ^e EAS		mJ
Power Dissipation ^b (T _C =25°C)		105	W
Power Dissipation ^b (T _A =25°C)	P_D	2.5	W
Junction and Storage Temperature Range	T _{J,} T _{STG}	-55 ~ +150	°C

Thermal Characteristics

	T		1
Parameter	Symbol	Maximum	Units
Junction-to-Ambient ^a (t ≤ 10s)	_	35	°C/W
Junction-to-Ambient ^{a,d} (Steady-State)	$R_{ heta JA}$	75	°C/W
Junction-to-Lead (Steady-State)	ReJL	7.5	°C/W



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Symbol	Parameter	Conditions	Min	Тур	Max	Units
Off Char	acteristics		·			
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V$, $I_{D} = 250uA$	60			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 60V , V _{GS} = 0V			1	uA
I_{GSS}	Gate-Body Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA
On Char	acteristics					
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250uA$	1		3	V
П	Drain-Source	V _{GS} = 10V , I _D = 30A		5.5	7	mΩ
R _{DS(ON))}	On-State Resistance	V _{GS} = 4.5V , I _D = 25A		8	12	mΩ
g FS	Forward Transconductance	V _{DS} = 10V , I _D = 30A		50		S
Drain-So	urce Diode Characteristics					
V_{SD}	Diode Forward Voltage	$V_{GS} = 0V$, $I_{S} = 1.0A$			1.3	V
Is	Maximum Body-Diode Continuous Current				80	Α
Dynamic	Characteristics					
C_{iss}	Input Capacitance			4226		pF
C_{oss}	Output Capacitance	$V_{DS} = 30V$, $V_{GS} = 0V$ f = 1.0MHz		280		pF
C_{rss}	Reverse Transfer Capacitance	1.1000112		236		pF
Switchin	g Characteristics					
Q_{g}	Total Gate Charge			90		nC
Q_gs	Gate-Source Charge	$V_{DS} = 30V$, $I_{D} = 30A$ $V_{GS} = 10V$		10		nC
Q_{gd}	Gate-Drain Charge	100		18		nC
$t_{D(ON})$	Turn-On Delay Time			9		ns
t _r	Turn-On Rise Time	$V_{DD} = 30V$, $ID = 30A$		7.6		ns
$t_{D(OFF)}$	Turn-Off Delay Time	V_{GS} = 10 V R_{GEN} = 1.8 ohm		42		ns
t _f	Turn-Off Fall Time			16		ns

a. Repetitive rating, Pulse width limited by junction temperature $T_{J(MAX)}$ =150 °C. Ratings are based on low frequency and duty cycles to keep initial T_{I} =25 °C

b. The power dissipation P_D is based on $T_{J(MAX)}$ =150 °C , using \leq 10s junction-to-ambient thermal resistance.

c. The value of $R_{\theta JA}$ is measured with the device mounted on $1in^2$ FR-4 board with 2oz. Copper, in a still air environment with T_A = 25°C. The value in any given application depends on the user's specific board design.

d. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

e. EAS condition: T_J=25 °C, V_{DD}=30V, V_G=10V, L=0.5mH, Rg=25 Ω , I_{AS}=26A



Typical Characteristics

Figure1: Output Characteristics

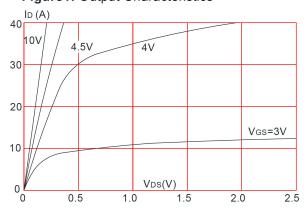


Figure 3:On-resistance vs. Drain Current

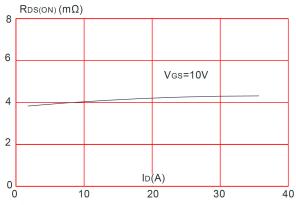


Figure 5: Gate Charge Characteristics

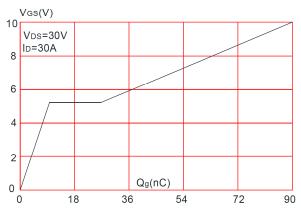


Figure 2: Typical Transfer Characteristics

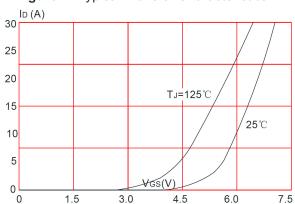


Figure 4: Body Diode Characteristics

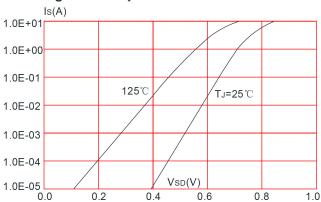
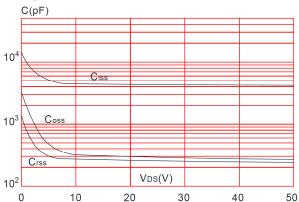


Figure 6: Capacitance Characteristics





Typical Characteristics

Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

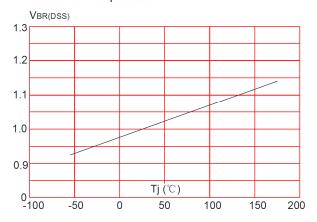


Figure 9: Maximum Safe Operating Area

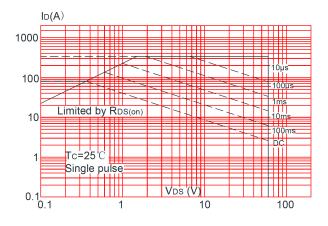


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

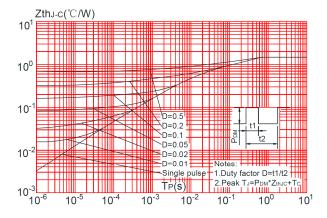


Figure 8: Normalized on Resistance vs. Junction Temperature

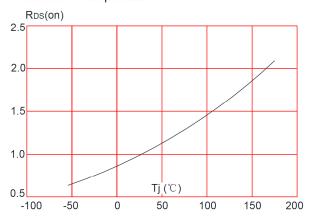
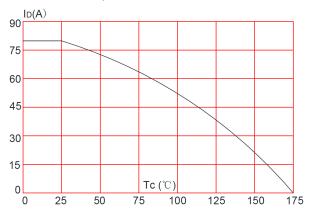
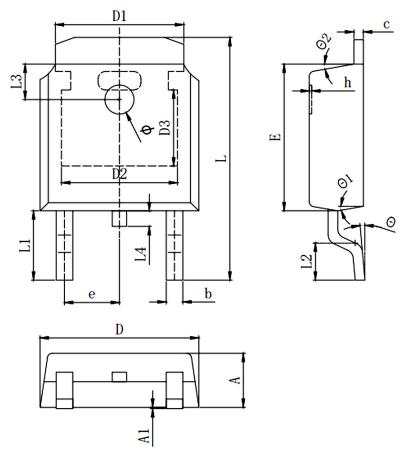


Figure 10: Maximum Continuous Drain Current vs. Case Temperature





TO-252 D-PAK Package



		Millimeters	
Symbols			
	MIN.	Mom.	MAX.
Α	2.200	2.300	2.400
A1	0.000		0.127
b	0.640	0.690	0.740
c(电镀后)	0.460	0.520	0.580
D	6.500	6.600	6.700
D1	5.334 REF		
D2	4.826 REF		
D3	3.166REF		
E	6.000	6.100	6.200
е	2.286 TYP		
h	0.000	0.100	0.200
L	9.900	10.100	10.300
L1	2.888 REF		
L2	1.400	1.550	1.700
L3	1.600 REF		
L4	0.600	0.800	1.000
Ф	1.100	1.200	1.300
θ	0°		8°
θ1	9° TYP		
θ2	9° TYP		

单击下面可查看定价,库存,交付和生命周期等信息

>>SiliconWisdom(矽睿半导体)